

<b>Notice of References Cited</b>	Application/Control No. 10/652,486		Applicant(s)/Patent Under Reexamination SANO ET AL.	
	Examiner Donna V. Lui		Art Unit 2629	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0085886	05-2003	Ide et al.	345/211
*	B	US-6,333,738	12-2001	Ide, Shigeo	345/211
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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